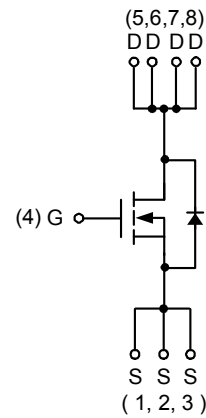
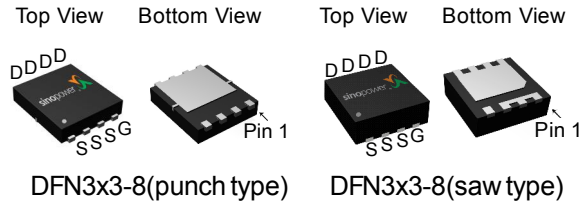


N-Channel Enhancement Mode MOSFET

Features

- 30V/12A,
 $R_{DS(ON)} = 10.5m\Omega(max.) @ V_{GS} = 10V$
 $R_{DS(ON)} = 15m\Omega(max.) @ V_{GS} = 4.5V$
- Avalanche Rated
- Reliable and Rugged
- Lead Free and Green Devices Available
 (RoHS Compliant)

Pin Description



N-Channel MOSFET

Applications

- Power Management in Notebook Computer, Portable Equipment and Battery Powered Systems.

Ordering and Marking Information

| | |
|---|--|
| <p>SM3314NS □□□-□□□</p> <div style="margin-left: 40px;"> <p>└─ Assembly Material</p> <p>└─ Handling Code</p> <p>└─ Temperature Range</p> <p>└─ Package Code</p> </div> | <p>Package Code QA : DFN3x3-8 (punch type) QG : DFN3x3-8 (saw type)</p> <p>Operating Junction Temperature Range C : -55 to 150 °C</p> <p>Handling Code TR : Tape & Reel (3000ea/reel)</p> <p>Assembly Material G : Halogen and Lead Free Device</p> |
| <p>SM3314NS QA/QG :</p> <div style="border: 1px solid black; padding: 2px; display: inline-block; margin-left: 20px;"> SM 3314 XXXXX </div> | <p>XXXXX - Lot Code</p> |

Note : SINOPOWER lead-free products contain molding compounds/die attach materials and 100% matte tin plate termination finish; which are fully compliant with RoHS. SINOPOWER lead-free products meet or exceed the lead-free requirements of IPC/JEDEC J-STD-020D for MSL classification at lead-free peak reflow temperature. SINOPOWER defines "Green" to mean lead-free (RoHS compliant) and halogen free (Br or Cl does not exceed 900ppm by weight in homogeneous material and total of Br and Cl does not exceed 1500ppm by weight).

SINOPOWER reserves the right to make changes to improve reliability or manufacturability without notice, and advise customers to obtain the latest version of relevant information to verify before placing orders.

Absolute Maximum Ratings ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

| Symbol | Parameter | Rating | Unit | |
|--|--|---------------------------|------------------|--------------------|
| Common Ratings ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted) | | | | |
| V_{DSS} | Drain-Source Voltage | 30 | V | |
| V_{GSS} | Gate-Source Voltage | ± 20 | | |
| T_J | Maximum Junction Temperature | 150 | $^\circ\text{C}$ | |
| T_{STG} | Storage Temperature Range | -55 to 150 | | |
| I_S | Diode Continuous Forward Current | $T_C = 25^\circ\text{C}$ | 40 ^a | A |
| I_D | Continuous Drain Current | $T_C = 25^\circ\text{C}$ | 40 ^a | |
| | | $T_C = 100^\circ\text{C}$ | 25 | |
| P_D | Maximum Power Dissipation | $T_C = 25^\circ\text{C}$ | 24 | W |
| | | $T_C = 100^\circ\text{C}$ | 9.6 | |
| $R_{\theta JC}$ | Thermal Resistance-Junction to Case | Steady State | 4.2 | $^\circ\text{C/W}$ |
| I_D | Continuous Drain Current | $T_A = 25^\circ\text{C}$ | 12 | A |
| | | $T_A = 70^\circ\text{C}$ | 9.5 | |
| I_{DM} | Pulsed Drain Current | $T_A = 25^\circ\text{C}$ | 40 ^b | |
| P_D | Maximum Power Dissipation | $T_A = 25^\circ\text{C}$ | 2 | W |
| | | $T_A = 70^\circ\text{C}$ | 1.3 | |
| $R_{\theta JA}$ | Thermal Resistance-Junction to Ambient | $t \leq 10\text{s}$ | 42 | $^\circ\text{C/W}$ |
| | | Steady State | 62 | |
| I_{AS}^c | Avalanche Current, Single pulse ($L=0.1\text{mH}$) | | 24 | A |
| E_{AS}^c | Avalanche Energy, Single pulse ($L=0.2\text{mH}$) | | 28.8 | mJ |

Note a : Package is limited to 40A.

Note b : Pulse width limited by max. junction temperature.

Note c : UIS tested and pulse width limited by maximum junction temperature 150°C (initial temperature $T_J = 25^\circ\text{C}$).

Electrical Characteristics ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)

| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|-------------------------------|----------------------------------|---|------|------|-----------|---------------|
| Static Characteristics | | | | | | |
| BV_{DSS} | Drain-Source Breakdown Voltage | $V_{GS}=0\text{V}, I_{DS}=250\mu\text{A}$ | 30 | - | - | V |
| I_{DSS} | Zero Gate Voltage Drain Current | $V_{DS}=24\text{V}, V_{GS}=0\text{V}$ $T_J=85^\circ\text{C}$ | - | - | 1 | μA |
| | | | - | - | 30 | |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{DS}=V_{GS}, I_{DS}=250\mu\text{A}$ | 1.5 | 1.8 | 2.5 | V |
| I_{GSS} | Gate Leakage Current | $V_{GS}=\pm 20\text{V}, V_{DS}=0\text{V}$ | - | - | ± 100 | nA |
| $R_{DS(ON)}^d$ | Drain-Source On-state Resistance | $V_{GS}=10\text{V}, I_{DS}=12\text{A}$ | - | 8.8 | 10.5 | m Ω |
| | | $V_{GS}=4.5\text{V}, I_{DS}=9\text{A}$ | - | 12 | 15 | |

Electrical Characteristics (Cont.) (T_A = 25°C Unless Otherwise Noted)

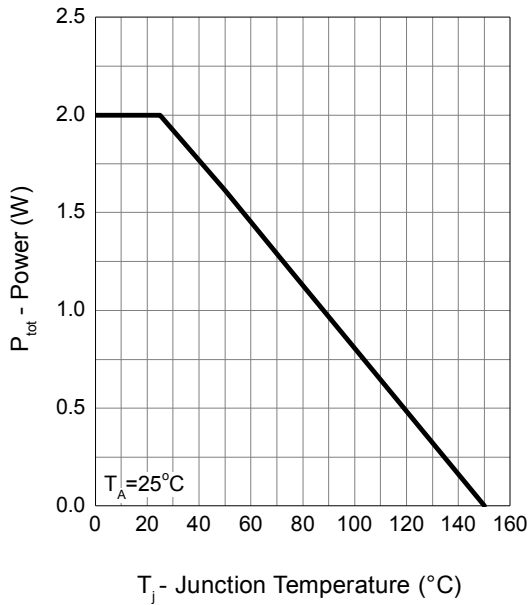
| Symbol | Parameter | Test Conditions | Min. | Typ. | Max. | Unit |
|--|------------------------------|---|------|------|------|------|
| Diode Characteristics | | | | | | |
| V _{SD} ^d | Diode Forward Voltage | I _{SD} =2A, V _{GS} =0V | - | 0.75 | 1.1 | V |
| t _{rr} ^e | Reverse Recovery Time | I _{SD} =12A, dI _{SD} /dt=100A/μs | - | 6.6 | - | ns |
| t _a | Charge Time | | - | 3.9 | - | |
| t _b | Discharge Time | | - | 2.6 | - | |
| Q _{rr} ^e | Reverse Recovery Charge | | - | 2 | - | nC |
| Dynamic Characteristics^e | | | | | | |
| R _G | Gate Resistance | V _{GS} =0V, V _{DS} =0V, F=1MHz | - | 2.5 | - | Ω |
| C _{iss} | Input Capacitance | V _{GS} =0V, V _{DS} =15V, Frequency=1.0MHz | 592 | 740 | 888 | pF |
| C _{oss} | Output Capacitance | | 133 | 190 | 247 | |
| C _{rss} | Reverse Transfer Capacitance | | 44 | 74 | 104 | |
| t _{d(ON)} | Turn-on Delay Time | V _{DD} =15V, R _L =15Ω, I _{DS} =1A, V _{GEN} =10V, R _G =6Ω | - | 9 | 17 | ns |
| t _r | Turn-on Rise Time | | - | 12 | 23 | |
| t _{d(OFF)} | Turn-off Delay Time | | - | 23 | 42 | |
| t _f | Turn-off Fall Time | | - | 6 | 12 | |
| Gate Charge Characteristics^e | | | | | | |
| Q _g | Total Gate Charge | V _{DS} =15V, V _{GS} =10V, I _{DS} =12A | - | 14.5 | 21 | nC |
| Q _g | Total Gate Charge | V _{DS} =15V, V _{GS} =4.5V, I _{DS} =12A | - | 6.8 | 9.5 | |
| Q _{gth} | Threshold Gate Charge | | - | 1.1 | 1.5 | |
| Q _{gs} | Gate-Source Charge | | - | 2.4 | 3.3 | |
| Q _{gd} | Gate-Drain Charge | | - | 3.9 | 5.4 | |

Note d : Pulse test ; pulse width ≤ 300 μs, duty cycle ≤ 2%.

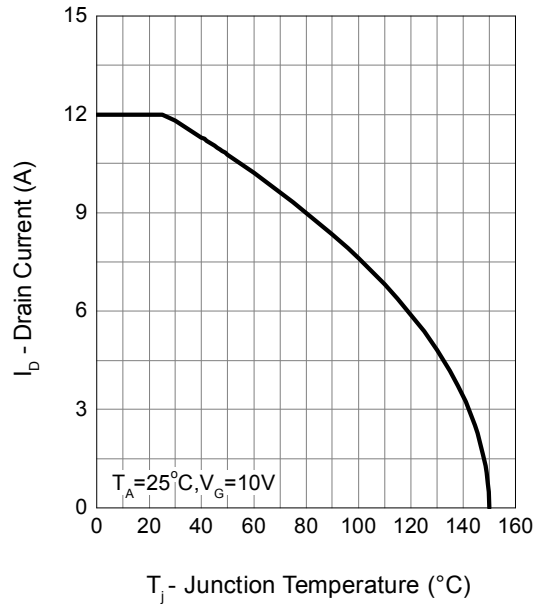
Note e : Guaranteed by design, not subject to production testing.

Typical Operating Characteristics

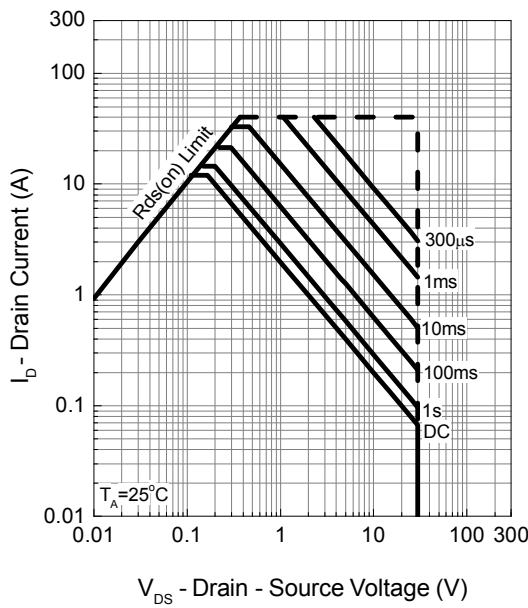
Power Dissipation



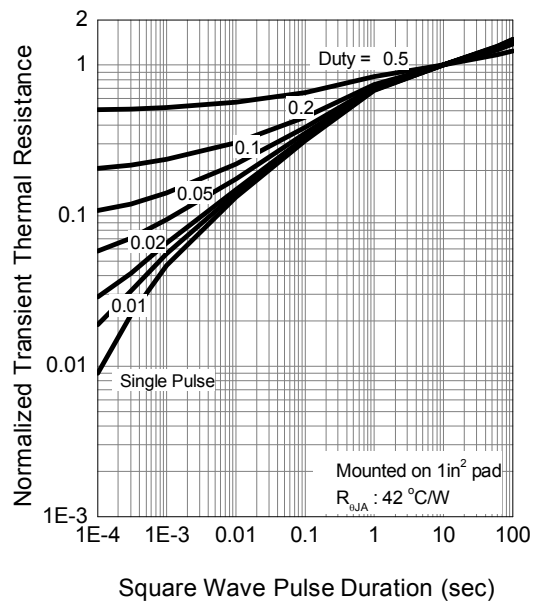
Drain Current



Safe Operation Area

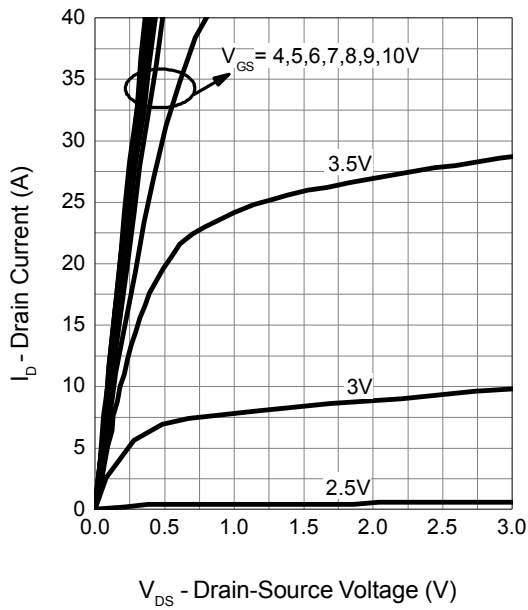


Thermal Transient Impedance

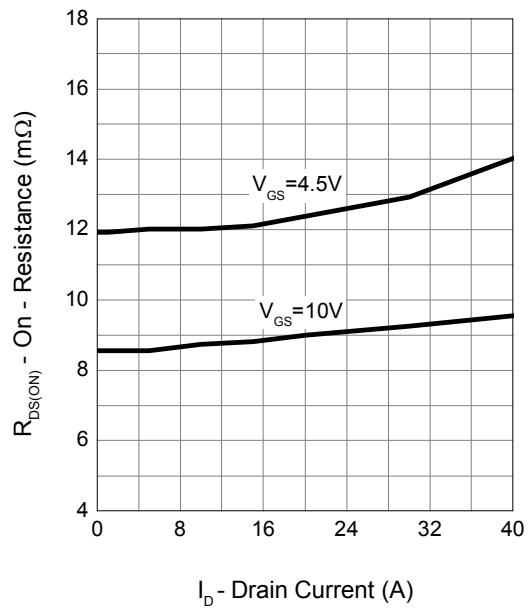


Typical Operating Characteristics (Cont.)

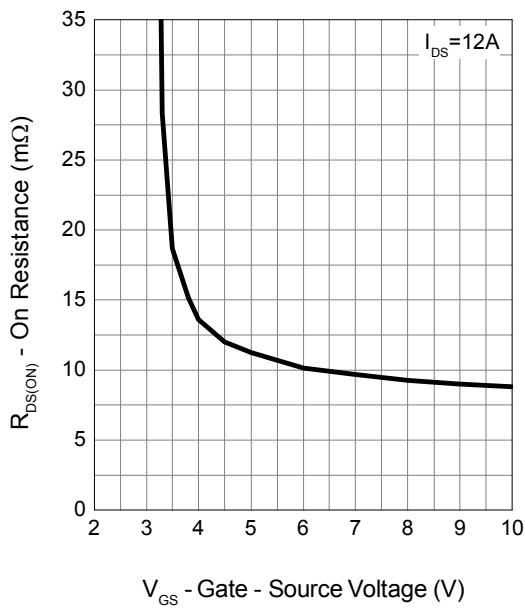
Output Characteristics



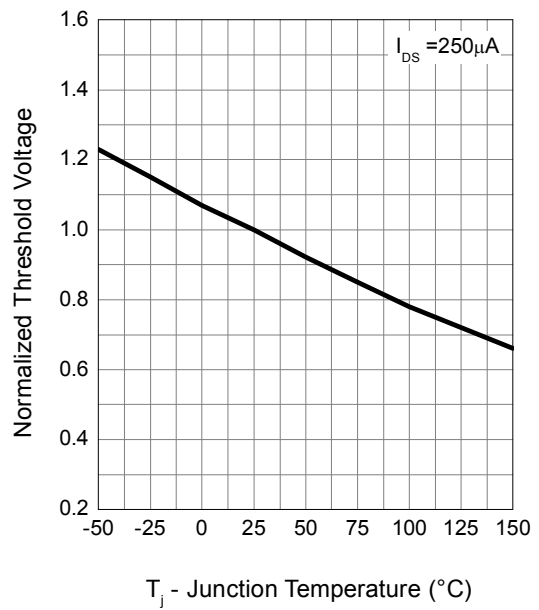
Drain-Source On Resistance



Gate-Source On Resistance

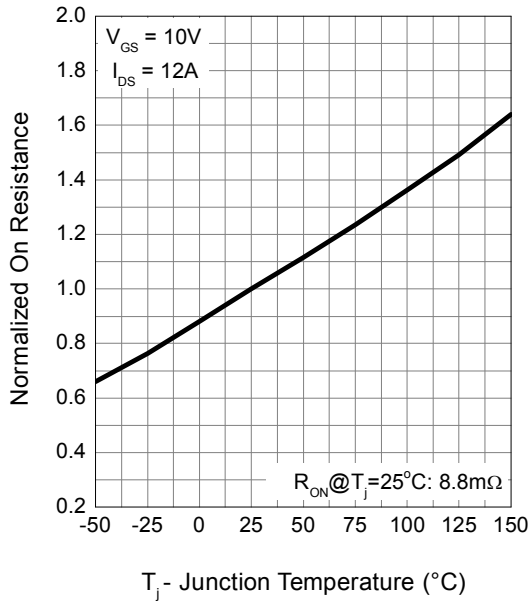


Gate Threshold Voltage

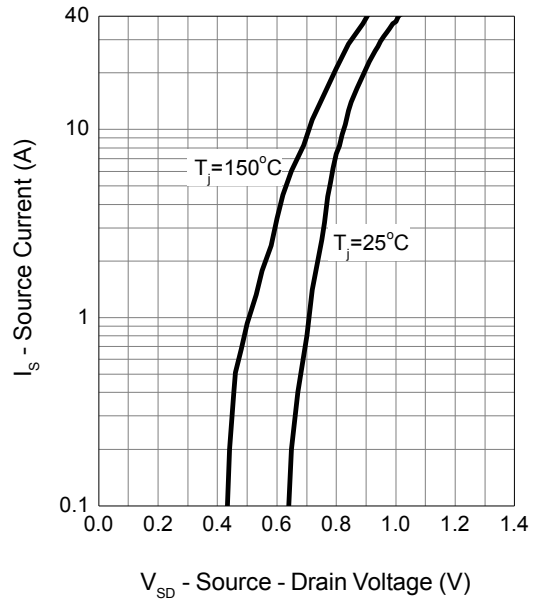


Typical Operating Characteristics (Cont.)

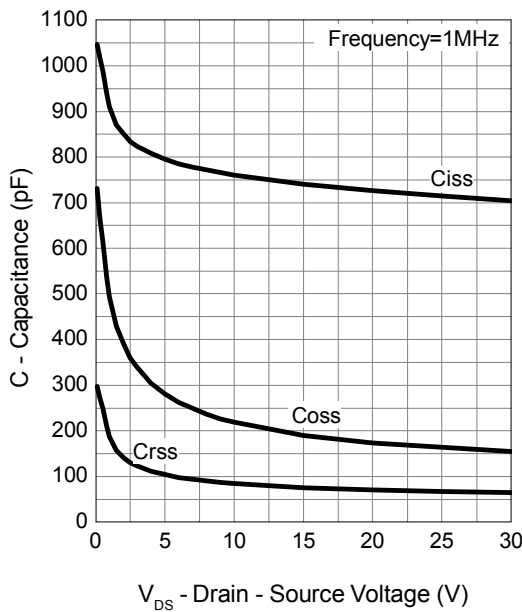
Drain-Source On Resistance



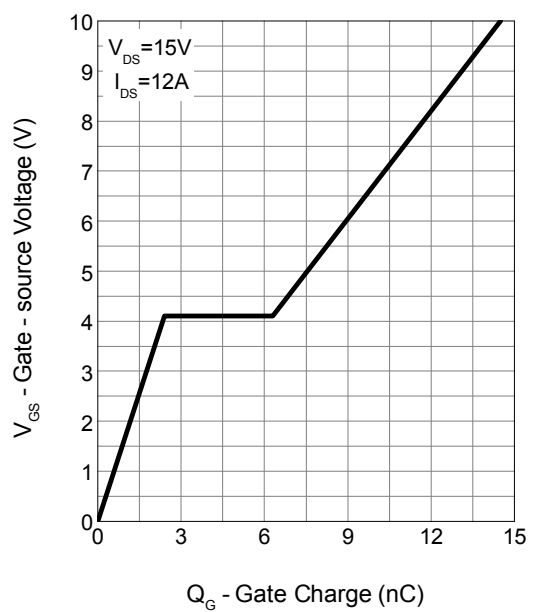
Source-Drain Diode Forward



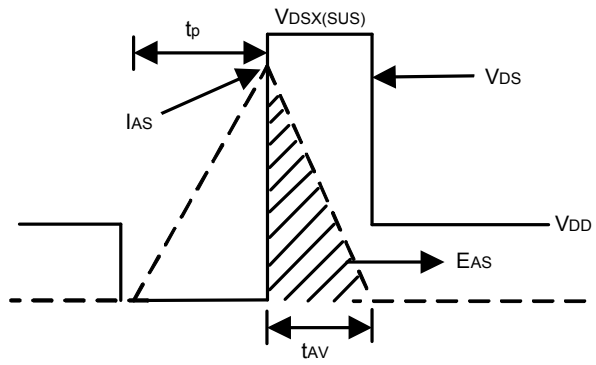
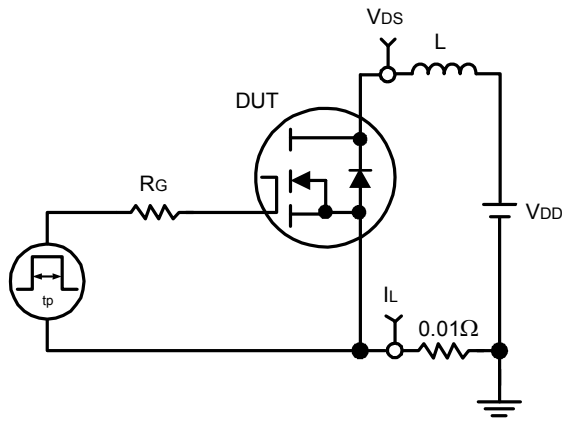
Capacitance



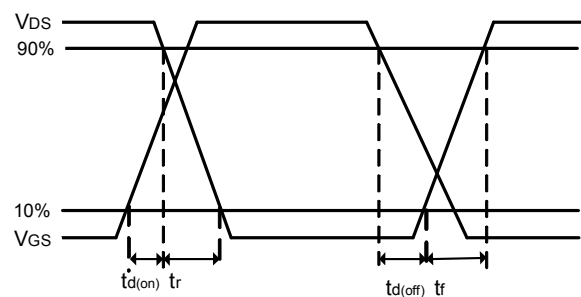
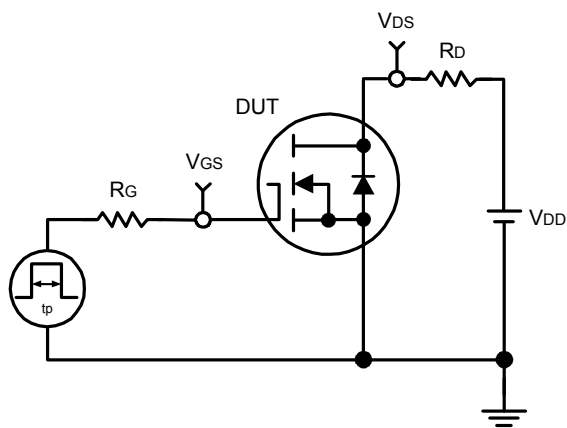
Gate Charge



Avalanche Test Circuit and Waveforms

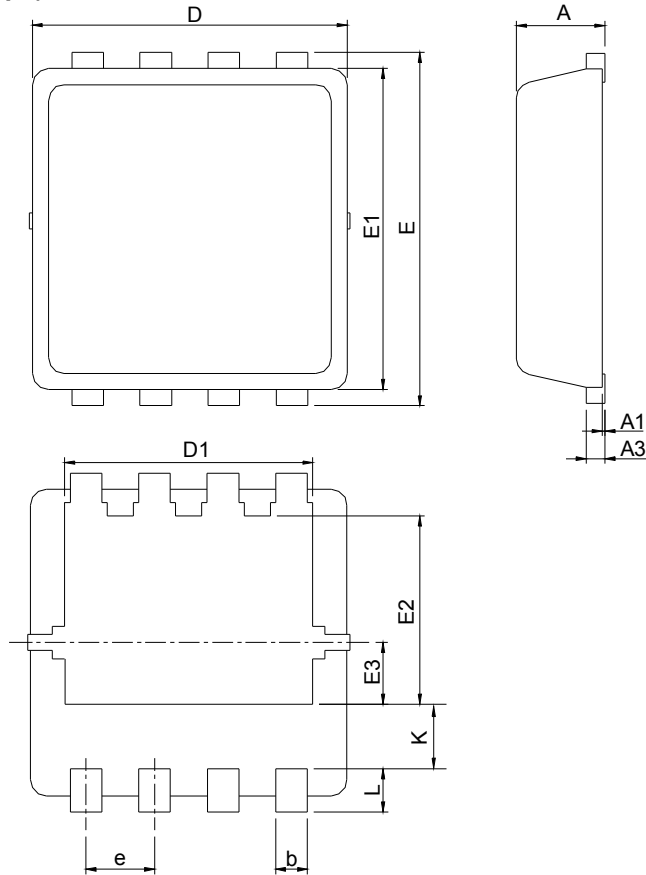


Switching Time Test Circuit and Waveforms



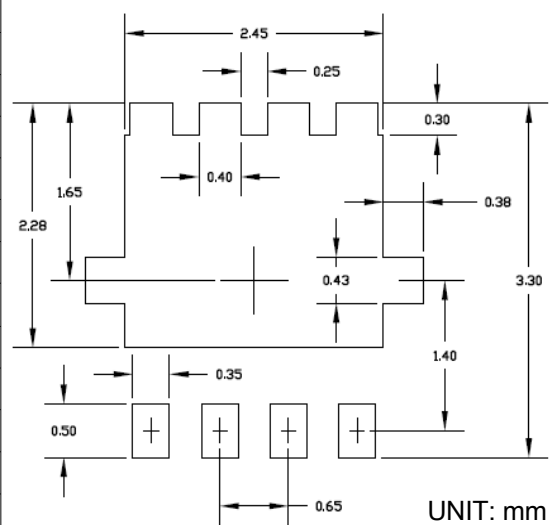
Package Information

DFN3x3-8(punch type)



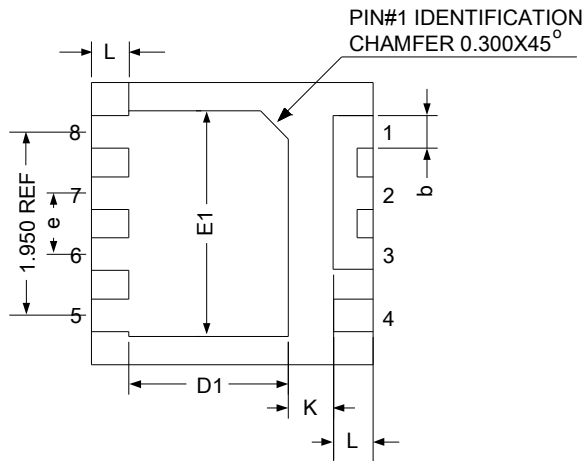
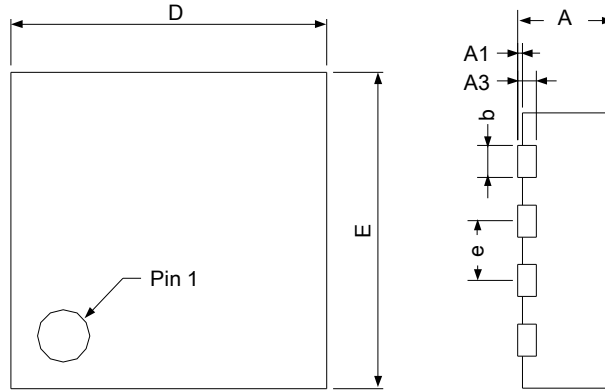
| SYMBOL | DFN3x3-8 | | | |
|--------|-------------|-------|-----------|-------|
| | MILLIMETERS | | INCHES | |
| | MIN. | MAX. | MIN. | MAX. |
| A | 0.80 | 1.00 | 0.031 | 0.039 |
| A1 | 0.00 | 0.05 | 0.000 | 0.002 |
| A3 | 0.10 | 0.25 | 0.004 | 0.010 |
| b | 0.24 | 0.35 | 0.009 | 0.014 |
| D | 2.90 | 3.10 | 0.114 | 0.122 |
| D1 | 2.25 | 2.45 | 0.089 | 0.096 |
| E | 3.10 | 3.30 | 0.122 | 0.130 |
| E1 | 2.90 | 3.10 | 0.114 | 0.122 |
| E2 | 1.65 | 1.85 | 0.065 | 0.073 |
| E3 | 0.56 | 0.58 | 0.022 | 0.023 |
| e | 0.65 BSC | | 0.026 BSC | |
| K | 0.475 | 0.775 | 0.019 | 0.031 |
| L | 0.30 | 0.50 | 0.012 | 0.020 |

RECOMMENDED LAND PATTERN



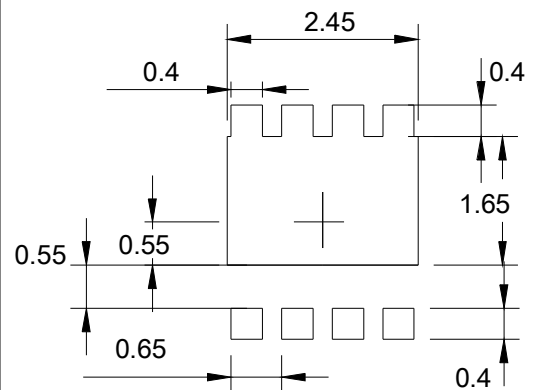
Package Information

DFN3x3-8(saw type)



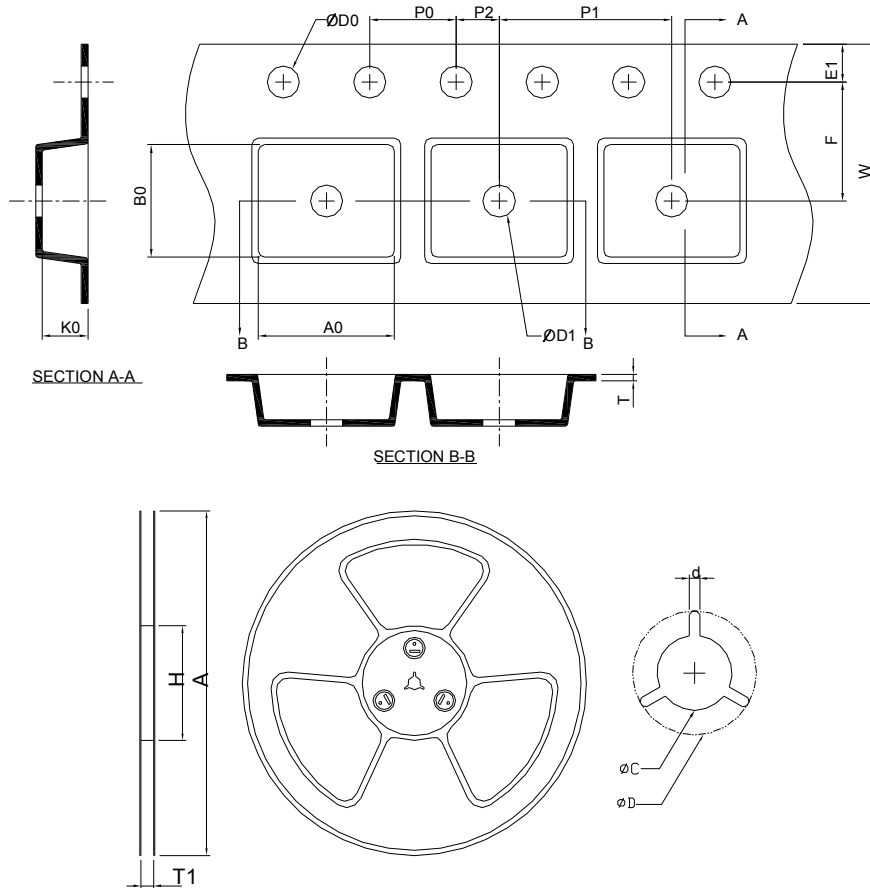
| SYMBOL | DFN3x3-8 | | | |
|--------|-------------|------|-----------|-------|
| | MILLIMETERS | | INCHES | |
| | MIN. | MAX. | MIN. | MAX. |
| A | 0.70 | 1.00 | 0.028 | 0.039 |
| A1 | 0.00 | 0.05 | 0.000 | 0.002 |
| A3 | 0.203 REF | | 0.008 REF | |
| b | 0.25 | 0.40 | 0.010 | 0.016 |
| D | 2.90 | 3.10 | 0.114 | 0.122 |
| E1 | 2.25 | 2.55 | 0.089 | 0.1 |
| E | 2.90 | 3.10 | 0.114 | 0.122 |
| D1 | 1.65 | 1.9 | 0.065 | 0.075 |
| e | 0.65 BSC | | 0.026 BSC | |
| L | 0.30 | 0.50 | 0.012 | 0.020 |
| K | 0.43 | - | 0.017 | - |

RECOMMENDED LAND PATTERN



UNIT: mm

Carrier Tape & Reel Dimensions

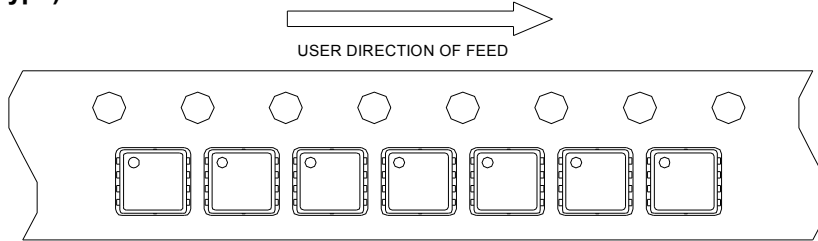


| Application | A | H | T1 | C | d | D | W | E1 | F |
|-------------|------------|----------|--------------------|--------------------|----------|------------------|-----------|-----------|-----------|
| DFN3x3-8 | 330.0±2.00 | 50 MIN. | 12.4+2.00 -0.00 | 13.0+0.50 -0.20 | 1.5 MIN. | 20.2 MIN. | 12.0±0.30 | 1.75±0.10 | 5.5±0.05 |
| | P0 | P1 | P2 | D0 | D1 | T | A0 | B0 | K0 |
| | 4.0±0.10 | 8.0±0.10 | 2.0±0.05 | 1.5+0.10 -0.00 | 1.5 MIN. | 0.6+0.00 -0.4 | 3.35±0.20 | 3.35±0.20 | 1.30±0.20 |

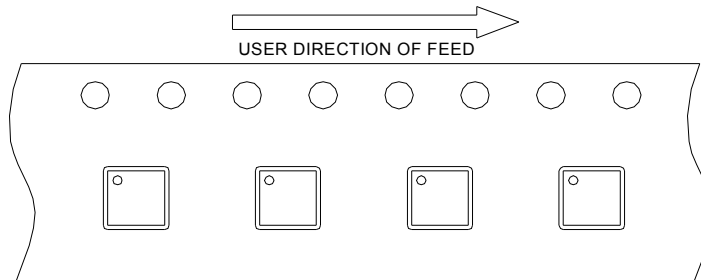
(mm)

Taping Direction Information

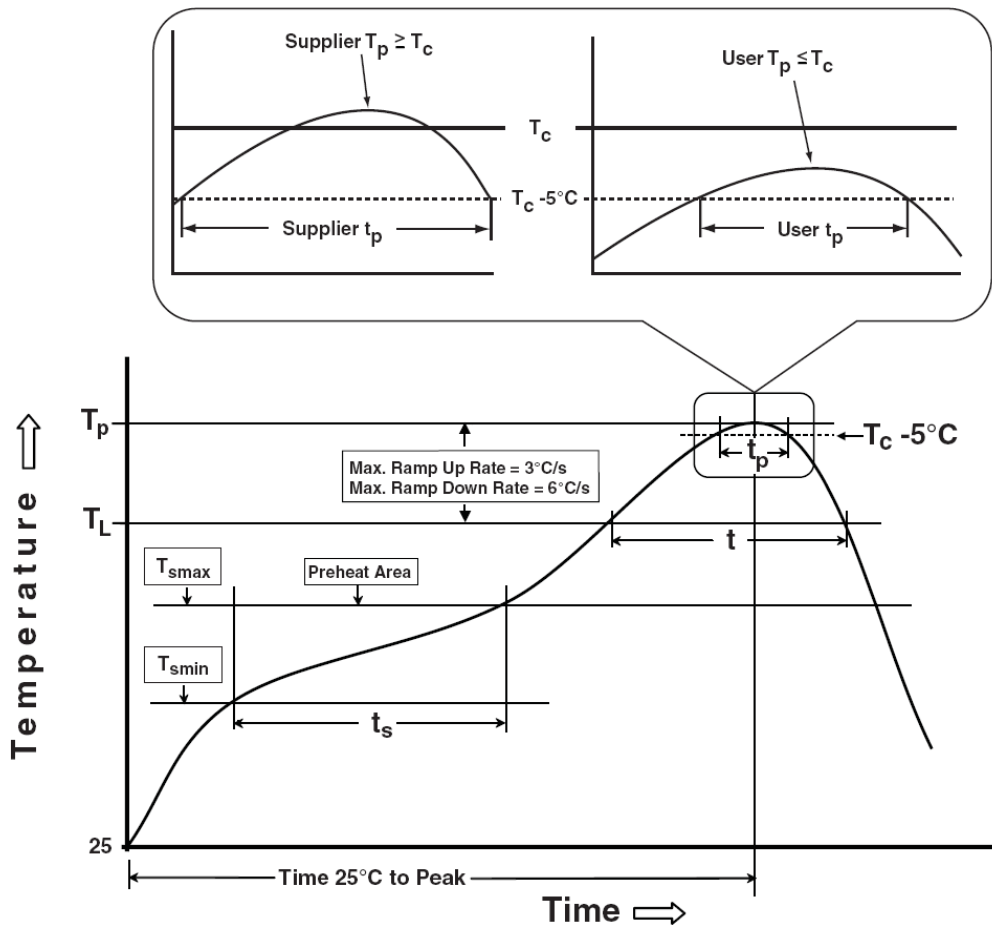
DFN3x3-8(punch type)



DFN3x3-8(saw type)



Classification Profile



Classification Reflow Profiles

| Profile Feature | Sn-Pb Eutectic Assembly | Pb-Free Assembly |
|---|------------------------------------|------------------------------------|
| Preheat & Soak | | |
| Temperature min (T_{smin}) | 100 °C | 150 °C |
| Temperature max (T_{smax}) | 150 °C | 200 °C |
| Time (T_{smin} to T_{smax}) (t_s) | 60-120 seconds | 60-120 seconds |
| Average ramp-up rate (T_{smax} to T_p) | 3 °C/second max. | 3°C/second max. |
| Liquidous temperature (T_L) | 183 °C | 217 °C |
| Time at liquidous (t_L) | 60-150 seconds | 60-150 seconds |
| Peak package body Temperature (T_p)* | See Classification Temp in table 1 | See Classification Temp in table 2 |
| Time (t_p)** within 5°C of the specified classification temperature (T_c) | 20** seconds | 30** seconds |
| Average ramp-down rate (T_p to T_{smax}) | 6 °C/second max. | 6 °C/second max. |
| Time 25°C to peak temperature | 6 minutes max. | 8 minutes max. |
| * Tolerance for peak profile Temperature (T_p) is defined as a supplier minimum and a user maximum. ** Tolerance for time at peak profile temperature (t_p) is defined as a supplier minimum and a user maximum. | | |

Table 1. SnPb Eutectic Process – Classification Temperatures (T_c)

| Package Thickness | Volume mm ³ <350 | Volume mm ³ ≥350 |
|-------------------|-----------------------------|-----------------------------|
| <2.5 mm | 235 °C | 220 °C |
| ≥2.5 mm | 220 °C | 220 °C |

Table 2. Pb-free Process – Classification Temperatures (T_c)

| Package Thickness | Volume mm ³ <350 | Volume mm ³ 350-2000 | Volume mm ³ >2000 |
|-------------------|-----------------------------|---------------------------------|------------------------------|
| <1.6 mm | 260 °C | 260 °C | 260 °C |
| 1.6 mm – 2.5 mm | 260 °C | 250 °C | 245 °C |
| ≥2.5 mm | 250 °C | 245 °C | 245 °C |

Reliability Test Program

| Test item | Method | Description |
|---------------|---------------|--|
| SOLDERABILITY | JESD-22, B102 | 5 Sec, 245°C |
| HTRB | JESD-22, A108 | 1000 Hrs, 80% of VDS max @ T_{jmax} |
| HTGB | JESD-22, A108 | 1000 Hrs, 100% of VGS max @ T_{jmax} |
| PCT | JESD-22, A102 | 168 Hrs, 100%RH, 2atm, 121°C |
| TCT | JESD-22, A104 | 500 Cycles, -65°C~150°C |

Customer Service

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